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|-----------------------------------|--|-------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination DEYCH ET AL. | |
| | | Examiner Allen C. Ho | Art Unit 2882 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------------|----------------|
| * | A | US-6,768,784 B1 | 07-2004 | Green et al. | 378/62 |
| * | B | US-6,594,339 B1 | 07-2003 | Alving et al. | 378/98.7 |
| * | C | US-6,501,819 B2 | 12-2002 | Unger et al. | 378/5 |
| * | D | US-6,442,238 B2 | 08-2002 | Meulenbrugge, Hendrik Jan | 378/98.8 |
| * | E | US-6,330,302 B1 | 12-2001 | Joosten, Johannes H. M. | 378/98.12 |
| * | F | US-4,686,695 | 08-1987 | Macovski, Albert | 378/146 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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